

# **TestForum 2021**

### Gothenburg, Sweden November 30<sup>th</sup> – December 1<sup>st</sup>, 2021

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#### Test Forum 2021 Local Organizer

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## **Call for Papers / Presentations**

The 2-day TestForum 2021, the 21st event in the series, is the major event for Test professionals in the Nordic area and the Baltic states. Every year the TestForum is attended by key people from the industry's test community as well as by international vendors of test and measurement equipment and solutions.

In 2021, the event will take place at Radisson Blu, Gothenburg, Sweden.

Nordic Test Forum hereby cordially invites you to participate and submit your contribution to TestForum 2021, which includes (but is not limited to) the following topics:

ASIC: BIST / Mixed-signal /

Future technology trends

and test challenges

manufacturing test

Best practices in

IDDQ / IDDT

- Functional Test
- Boundary Scan
- Embedded Instruments
- RF Testing
- AOI / AXI / SPI
- ICT / Flying Probe •
- Test economics
- Power Test
- Fixturing/Interfaces
- Board test SW, BIST, diagnostics
  - Quality methods and tools
- Robotics in testing
- Preventive test / Prognostics
- Design to Test transfer / Design for Test
- Test efficiency and optimization
- Big Data acquisition /
- **Submissions** TestForum seeks full papers and/or presentations in the area of test of electronics, including R&D, Application Contributions, Best Practices, Emerging Ideas, etc. You are welcome to submit contributions also outside the above topics as long as they stay within the field of electronics test. Focus shall be on new and upcoming challenges, opportunities, techniques and best practices in electronics test technology rather than on particular products.

#### **Proceedings**

The accepted contributions of authors that wish to provide the corresponding materials will be delivered in electronic format at the Nordic Test Forum event.

#### The Format of the Event

- The event format will be a two-day workshop and a small exhibition attached to it.
- November 29<sup>th</sup> in the evening there is the AGM of the NTF.
- The mix of presentations will decide the number of sessions.
- The presentations will be 30 minutes each: 25 minutes of speech and 5 minutes for questions and comments.
- In the exhibition, attendees will have a chance to see the latest equipment and talk to exhibitors.

#### **Key Dates**

- Abstract submission:
- Notification of acceptance:
- Conference registration opens:
- Presentation slides:

#### **Further Information and Submissions**

Jytte Schneider Phone: +45 2579 1120 Email: jytte.schneider@nordictestforum.org 31st August 2021 17th September 2021 19th September 2021 1<sup>st</sup> November 2021

Visit the NTF web pages at: http://www.nordictestforum.org



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